

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10595014	OYAMA ET AL.
Examiner	Art Unit	
MARCOS BATISTA	4134	

SEARCHED

Class	Subclass	Date	Examiner
455	411	3/13/2008	mb
370	320	3/13/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Steve D'Aghosta	3/13/2008	mb
Consulted w/ lab TA Yogesh Aggarwal	3/13/2008	mb
Consulted with Lun-Yi Lao	3/13/2008	mb
Inventor's Name Search	3/13/2008	mb
East Search	3/13/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner